



• General Description

It combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$. This device is ideal for motor driver, load switch and DC-DC applications.

• Features

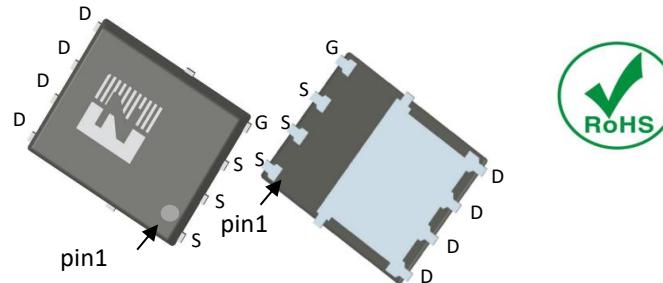
- Advance Trench technology
- Low $R_{DS(ON)}$ to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

• Application

- BLDC Motor driver
- Load Switch
- DC-DC

• Product Summary

$V_{DS} = -40V$
$R_{DS(ON)} = 6.8m\Omega$
$I_D = -75A$



DFN5 x 6

• Ordering Information:

Part NO.	ZM060P04N
Marking	ZM060P04
Packing Information	REEL TAPE
Basic ordering unit (pcs)	3000

• Absolute Maximum Ratings ($T_c = 25^\circ C$)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	-40	V
Gate-Source Voltage	V_{GS}	± 25	V
Continuous Drain Current	$I_D @ T_c = 25^\circ C$	-75	A
	$I_D @ T_c = 75^\circ C$	-57	A
	$I_D @ T_c = 100^\circ C$	-45	A
Pulsed Drain Current ^①	I_{DM}	-165	A
Total Power Dissipation	$P_D @ T_c = 25^\circ C$	83	W
Total Power Dissipation	$P_D @ T_A = 25^\circ C$	3	W
Operating Junction Temperature	T_J	-55 to 150	°C
Storage Temperature	T_{STG}	-55 to 150	°C
Single Pulse Avalanche Energy	E_{AS}	150	mJ
ESD Level (HBM)		Class 2	


•Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	R _{thJC}	-	-	2.0	°C/W
Thermal resistance, junction - ambient	R _{thJA}	-	-	62.5	°C/W
Soldering temperature, wavesoldering for 10s	T _{sold}	-	-	260	°C

•Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =-250uA	-40			V
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} =V _{DS} , I _D =-250uA	-1.3		-2.5	V
Drain-Source Leakage Current	I _{DSS}	V _{DS} =-40V, V _{GS} =0V			1.0	uA
Gate- Source Leakage Current	I _{GSS}	V _{GS} =±20V, V _{DS} =0V			±100	nA
Static Drain-source On Resistance	R _{DS(ON)}	V _{GS} =-10V, I _D =-40A		6.8	8.8	mΩ
		V _{GS} =-4.5V, I _D =-25A		9.5	12	mΩ
Forward Transconductance	g _{FS}	V _{DS} =-10V, I _D =-10A		28		s
Source-drain voltage	V _{SD}	I _S =40A			1.28	V

•Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Input capacitance	C _{iss}	f = 1MHz V _{DS} =-25V	-	6210	-	pF
Output capacitance	C _{oss}		-	468	-	
Reverse transfer capacitance	C _{rss}		-	397	-	

•Gate Charge characteristics(T_a = 25°C)

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Total gate charge	Q _g	V _{DD} = -25V I _D =- 5A V _{GS} = -10V	-	106	-	nC
Gate - Source charge	Q _{gs}		-	13	-	
Gate - Drain charge	Q _{gd}		-	20	-	



Fig.1 Power Dissipation Derating Curve

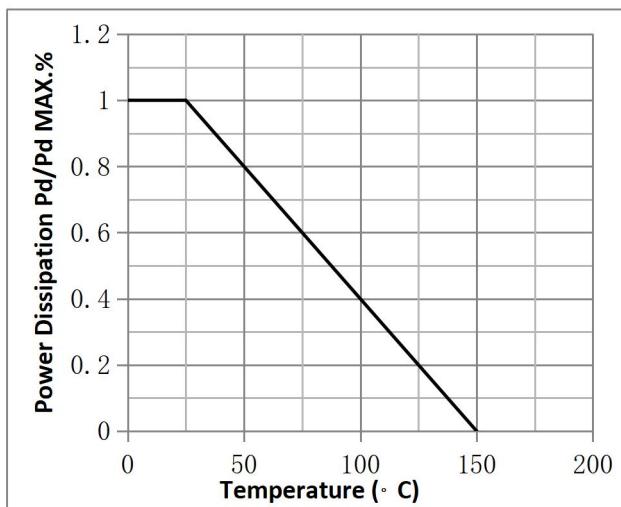


Fig.2 Typical output Characteristics

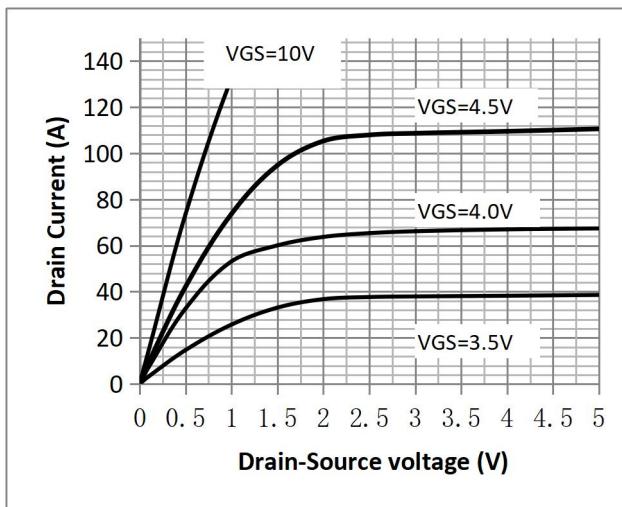


Fig.3 Threshold Voltage V.S Junction Temperature

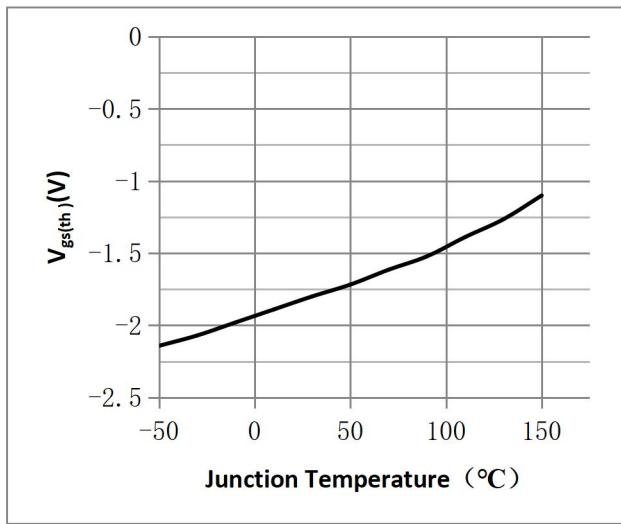


Fig.4 Resistance V.S Drain Current

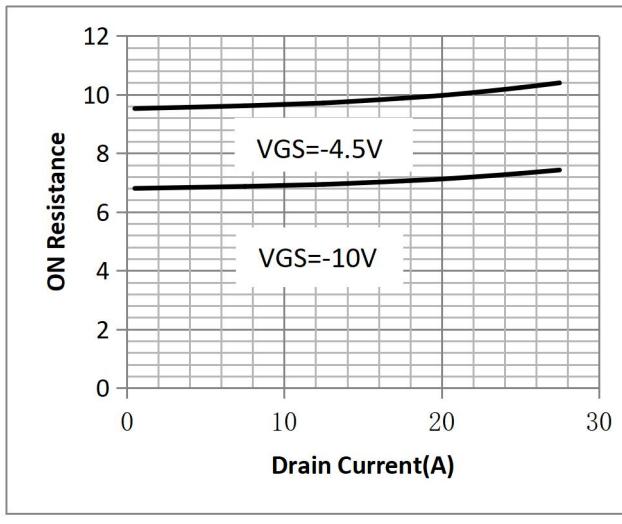


Fig.5 On-Resistance VS Gate Source Voltage

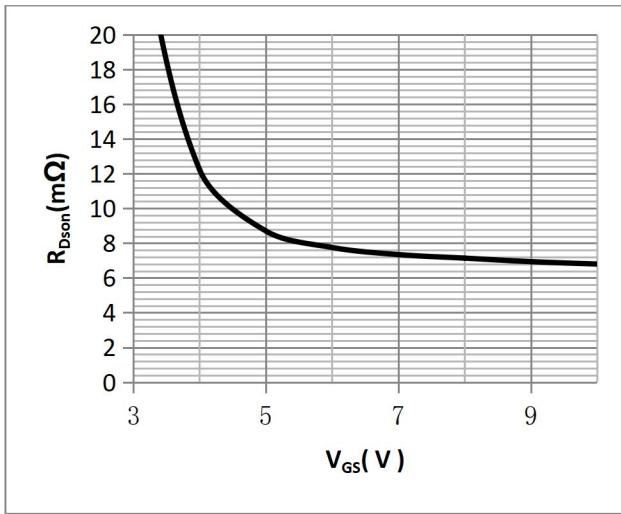


Fig.6 On-Resistance V.S Junction Temperature

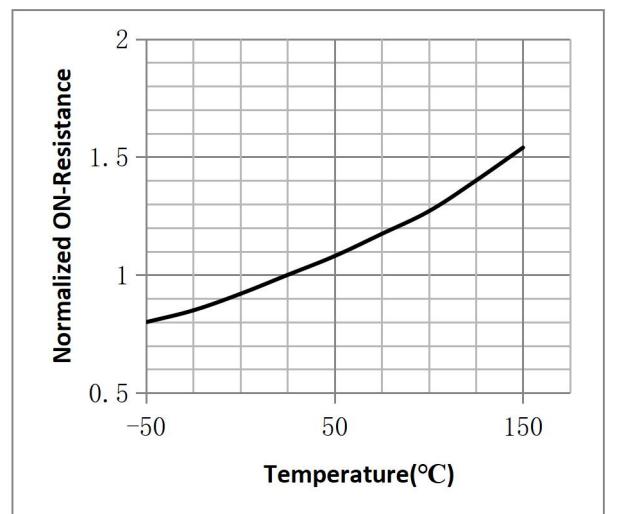




Fig.7 SOA Maximum Safe Operating Area

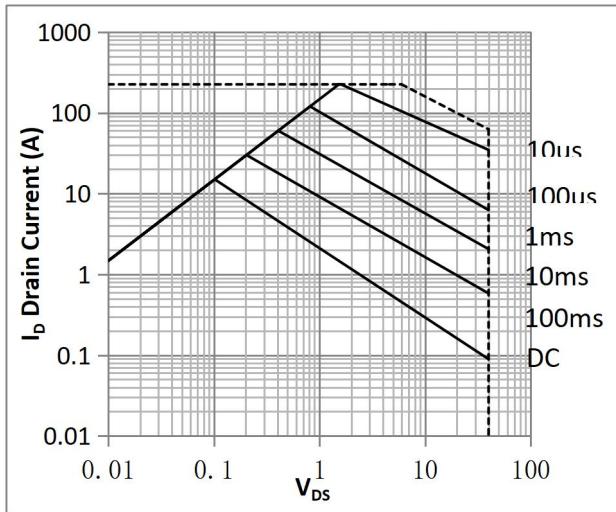


Fig.8 ID-Junction Temperature

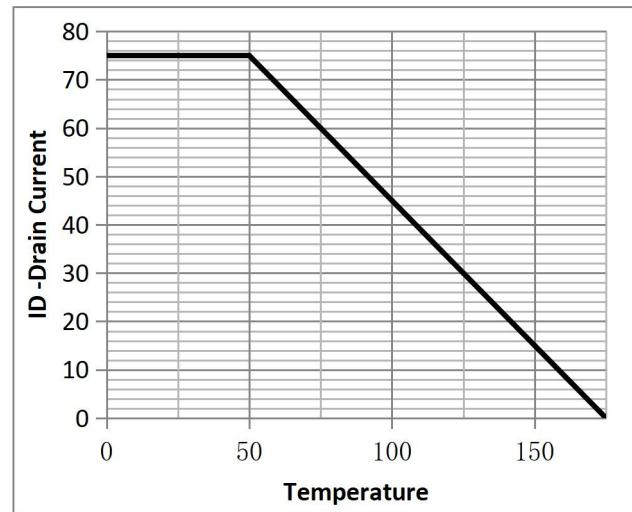


Figure.9 Diode Forward Voltage vs. Current

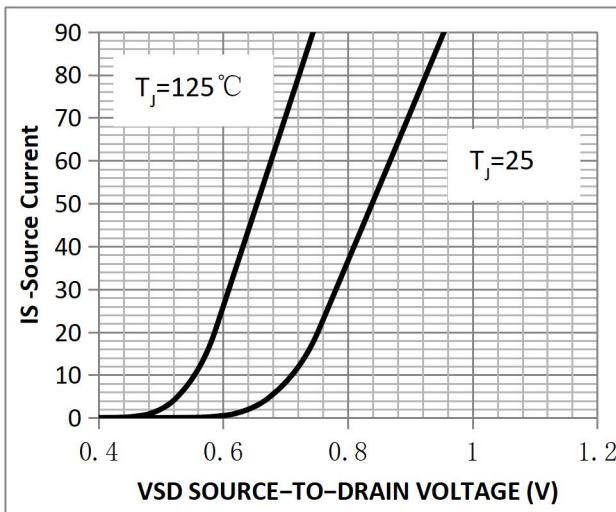


Figure.10 Transfer Characteristics

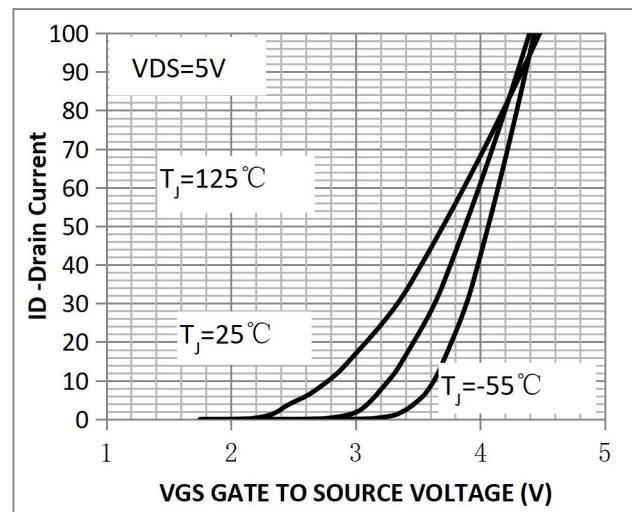


Fig.11 Gate Charge Characteristics

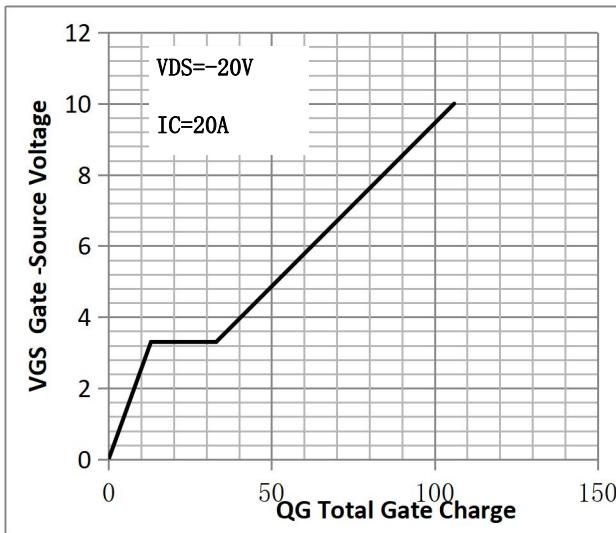


Fig.12 Capacitance vs Vds

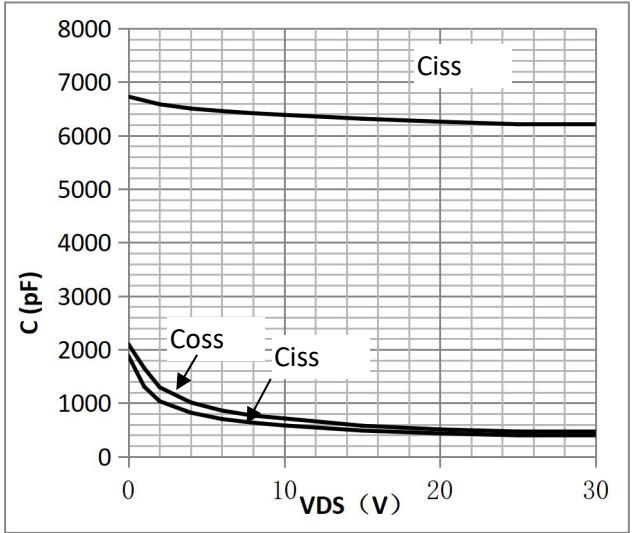




Fig.13 Switching Time Measurement Circuit

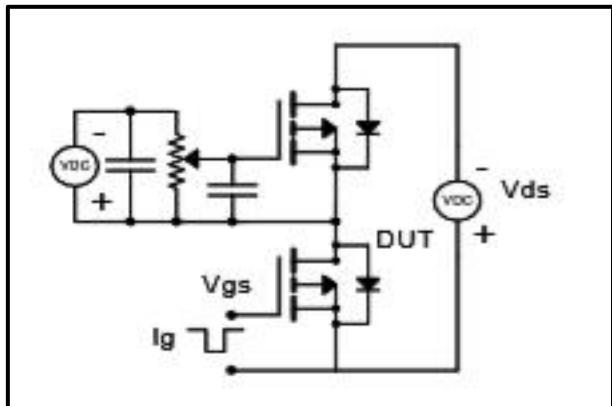


Fig.14 Gate Charge Waveform

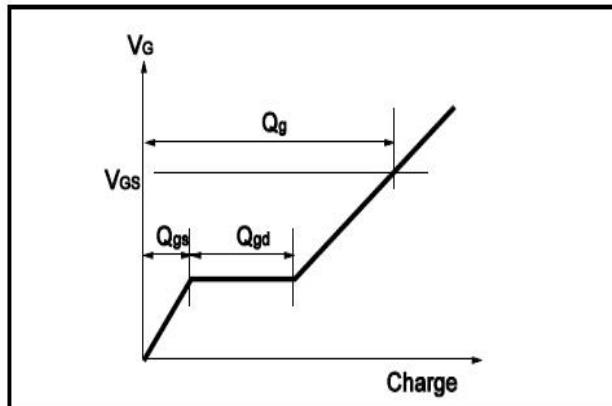


Fig.15 Switching Time Measurement Circuit

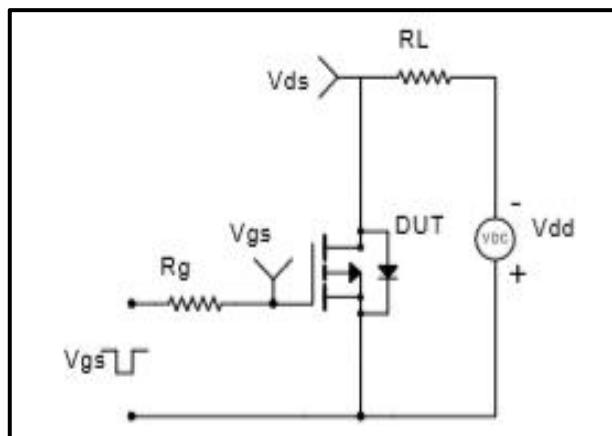


Fig.16 Gate Charge Waveform

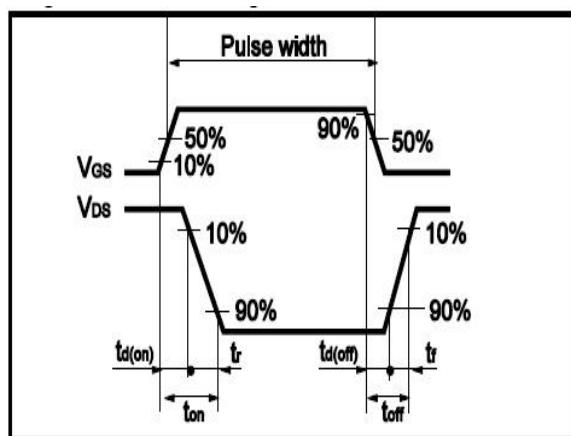


Fig.17 Avalanche Measurement Circuit

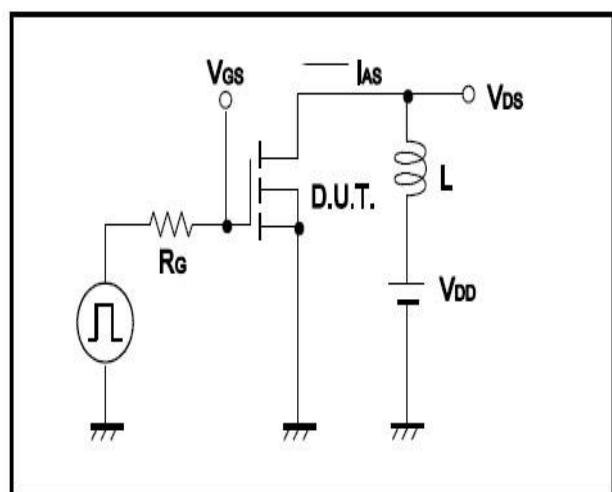
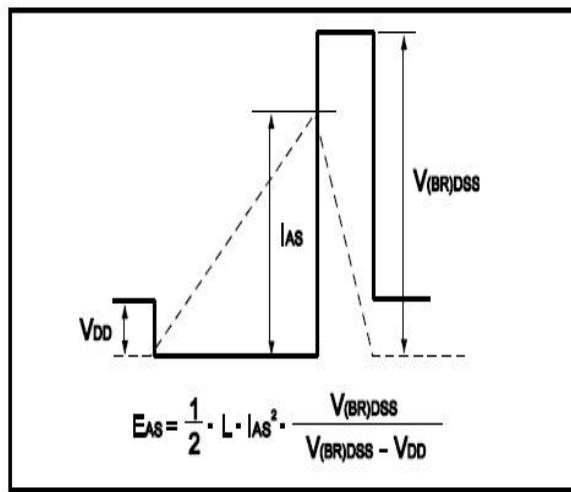


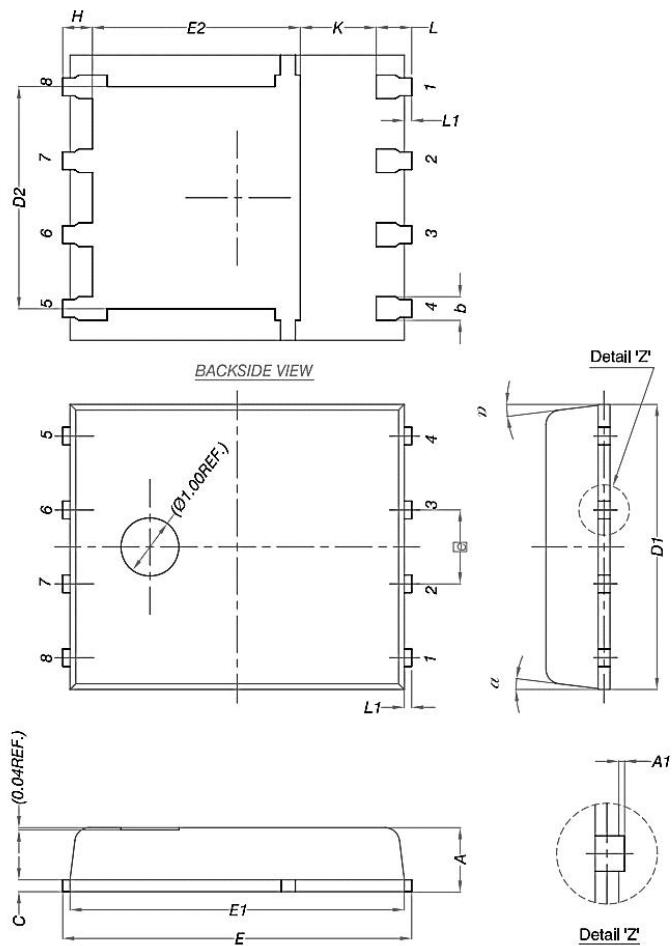
Fig.18 Avalanche Waveform





•Dimensions (DFN5×6)

Unit: mm





DIM.	MILLIMETERS		
	MIN.	NOM.	MAX.
A	0.90	1.00	1.10
A1	0	-	0.05
b	0.33	0.41	0.51
C	0.20	0.25	0.30
D1	4.80	4.90	5.00
D2	3.61	3.81	3.96
E	5.90	6.00	6.10
E1	5.70	5.75	5.80
E2	3.38	3.58	3.78
e	1.27 BSC		
H	0.41	0.51	0.61
K	1.10	-	-
L	0.51	0.61	0.71
L1	0.06	0.13	0.20
α	0°	-	12°

Note: ① Pulse Test: Pulse width ≤ 300μs, Duty cycle ≤ 2% ;

② Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;

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